Notice of References Cited Application/Control No. 10/570,646 Examiner Jacob F. Bétit Applicant(s)/Patent Under Reexamination HAKALA ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | Α | US-6,181,878 B1 | 01-2001 | Honda, Tsutomu | 396/310 |
| * | В | US-6,222,583 B1 | 04-2001 | Matsumura et al. | 348/113 |
| * | C | US-6,437,797 B1 | 08-2002 | Ota, Yoshinori | 345/638 |
| * | ם | US-6,462,778 B1 | 10-2002 | Abram et al. | 348/239 |
| * | Е | US-6,469,698 B2 | 10-2002 | Fukahori, Hidehiko | 345/204 |
| * | F | US-2003/0050982 A1 | 03-2003 | Chang, Sam M. | 709/206 |
| * | G | US-6,625,334 B1 | 09-2003 | Shiota et al. | 382/305 |
| * | Н | US-6,657,661 B1 | 12-2003 | Cazier, Robert | 348/231.2 |
| * | _ | US-2005/0234905 A1 | 10-2005 | Endler et al. | 707/005 |
| * | J | US-7,002,625 B2 | 02-2006 | Takahashi, Kazuhiro | 348/231.2 |
| | κ | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | , Name | Classification |
|---|---|--|-----------------|---------|-----------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | · |
| | s | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| | NON- ATEN DOCUMENTS | | | | | | |
|---|---------------------|---|--|--|--|--|--|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | | |
| | U | | | | | | |
| | V | | | | | | |
| | w | | | | | | |
| | x | | | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.